

RADIO TEST REPORT

Test Report No. 15027824H-A-R2

Customer	DENSO CORPORATION
Description of EUT	Millimeter Wave Radar Sensor
Model Number of EUT	DNMWR017
FCC ID	HYQDNMWR017
Test Regulation	FCC Part 95 Subpart M
Test Result	Complied
Issue Date	June 3, 2024
Remarks	-

Representative test engineer	Approved by
J. Fragatomi	Ryata Yamanaka
Junki Nagatomi Engineer	Ryota Yamanaka Engineer
	CERTIFICATE 5107.02
	is outside the accreditation scopes in UL Japan, Inc.
There is no testing item of "Non-accreditation".	

Report Cover Page - Form-ULID-003532 (DCS:13-EM-F0429) Issue# 23.0

Test Report No. 15027824H-A-R2 Page 2 of 41

ANNOUNCEMENT

- This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
- The results in this report apply only to the sample tested. (Laboratory was not involved in sampling.)
- This sample tested is in compliance with the limits of the above regulation.
- The test results in this test report are traceable to the national or international standards.
- This test report must not be used by the customer to claim product certification, approval, or endorsement by the A2LA accreditation body.
- This test report covers Radio technical requirements.
 It does not cover administrative issues such as Manual or non-Radio test related Requirements.
 (if applicable)
- The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
- The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan, Inc. has been accredited.
- The information provided from the customer for this report is identified in SECTION 1.
- For test report(s) referred in this report, the latest version (including any revisions) is always referred.

REVISION HISTORY

Original Test Report No.: 15027824H-A

This report is a revised version of 15027824H-A-R1. 15027824H-A-R1 is replaced with this report.

Revision	Test Report No.	Date	Page Revised Contents
- (Original)	15027824H-A	December 25, 2023	-
1	15027824H-A-R1	May 24, 2024	Correction of the all duty factor to "-" in the Average Power part of Radiated Power test data.
1	15027824H-A-R1	May 24, 2024	Correction of the following values for Modulation characteristics test (Tx (Mode 1) FCM 2); - CW section Total: from 731.276 us to 653.476 us - FCM2 section Total: from 2.609 ms to 2.942 ms - Duty: from 5.2 % to 5.9 % - Duty Factor: from 12.83 dB to 12.30 dB
2	15027824H-A-R2	June 3, 2024	Addition of the following Average Power in the Duty Factor value for the Radiated Power test; - FCM 1 (Low, High): 4.97 dB - FCM 2: 12.30 dB

Test Report No. 15027824H-A-R2 Page 3 of 41

Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	ICES	Interference-Causing Equipment Standard	
AC	Alternating Current	IEC	International Electrotechnical Commission	
AFH	Adaptive Frequency Hopping	IEEE	Institute of Electrical and Electronics Engineers	
AM	Amplitude Modulation	IF	Intermediate Frequency	
Amp, AMP	Amplifier	ILAC	International Laboratory Accreditation Conference	
ANSI	American National Standards Institute	ISED	Innovation, Science and Economic Development Canada	
Ant, ANT	Antenna	ISO	International Organization for Standardization	
AP	Access Point	JAB	Japan Accreditation Board	
ASK	Amplitude Shift Keying	LAN	Local Area Network	
Atten., ATT	Attenuator	LIMS	Laboratory Information Management System	
AV	Average	MCS	Modulation and Coding Scheme	
BPSK	Binary Phase-Shift Keying	MRA	Mutual Recognition Arrangement	
BR	Bluetooth Basic Rate	N/A	Not Applicable	
BT	Bluetooth	NIST	National Institute of Standards and Technology	
BT LE	Bluetooth Low Energy	NS	No signal detect.	
BW	BandWidth	NSA	Normalized Site Attenuation	
Cal Int	Calibration Interval	NVLAP	National Voluntary Laboratory Accreditation Program	
CCK	Complementary Code Keying	OBW	Occupied Band Width	
Ch., CH	Channel	OFDM	Orthogonal Frequency Division Multiplexing	
CISPR	Comite International Special des Perturbations Radioelectriques	P/M	Power meter	
CW	Continuous Wave	PCB	Printed Circuit Board	
DBPSK	Differential BPSK	PER	Packet Error Rate	
DC	Direct Current	PHY	Physical Layer	
D-factor	Distance factor	PK	Peak	
DFS	Dynamic Frequency Selection	PN	Pseudo random Noise	
DQPSK	Differential QPSK	PRBS	Pseudo-Random Bit Sequence	
DSSS	Direct Sequence Spread Spectrum	PSD	Power Spectral Density	
EDR	Enhanced Data Rate	QAM	Quadrature Amplitude Modulation	
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	QP	Quasi-Peak	
EMC	ElectroMagnetic Compatibility	QPSK	Quadri-Phase Shift Keying	
EMI	ElectroMagnetic Interference	RBW	Resolution Band Width	
EN	European Norm	RDS	Radio Data System	
ERP, e.r.p.	Effective Radiated Power	RE	Radio Equipment	
EU	European Union	RF	Radio Frequency	
EUT	Equipment Under Test	RMS	Root Mean Square	
Fac.	Factor	RSS	Radio Standards Specifications	
FCC	Federal Communications Commission	Rx	Receiving	
FHSS	Frequency Hopping Spread Spectrum	SA, S/A	Spectrum Analyzer	
FM	Frequency Modulation	SG	Signal Generator	
Freq.	Frequency	SVSWR	Site-Voltage Standing Wave Ratio	
FSK	Frequency Shift Keying	TR	Test Receiver	
GFSK	Gaussian Frequency-Shift Keying	Tx	Transmitting	
GNSS	Global Navigation Satellite System	VBW	Video BandWidth	
	,			
GPS	Global Positioning System	Vert.	Vertical	

CONTENTS	PAGE
SECTION 1: Customer Information	5
SECTION 2: Equipment Under Test (EUT)	5
SECTION 3: Test specification, procedures & results	6
SECTION 4: Operation of EUT during testing	9
SECTION 5: Radiated Spurious Emission	
SECTION 6: Frequency Stability	
APPENDIX 1: Test data	
Occupied bandwidth	
Radiated Power	
Modulation characteristics	
Field strength of spurious radiation	
Frequency Stability	
APPENDIX 2: Test instruments	34
APPENDIX 3: Photographs of test setup	
Radiated Power	36
Field strength of spurious radiation	
Worst Case Position	
Frequency Stability	

Test Report No. 15027824H-A-R2 Page 5 of 41

SECTION 1: Customer Information

Company Name	DENSO CORPORATION
Address	1-1, Showa-cho, Kariya-shi, Aichi-ken, 448-8661, Japan
Telephone Number	+81-566-55-5772
Contact Person	Kousaku Fukuda

The information provided from the customer is as follows;

- Customer, Description of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer Information
- SECTION 2: Equipment Under Test (EUT) other than the Receipt Date and Test Date
- SECTION 4: Operation of EUT during testing
- * The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment Under Test (EUT)

2.1 Identification of EUT

Description	Millimeter Wave Radar Sensor
Model Number	DNMWR017
Serial Number	Refer to SECTION 4.2
Condition	Pre-production
	(Not for Sale: This sample is equivalent to production version.)
Modification	No Modification by the test lab
Receipt Date	October 29, 2023
Test Date	November 2 to 20, 2023

2.2 Product Description

General Specification

Rating	DC 12 V (Car battery), DC 5.8 V to 16 V (Operating range)
Operating temperature	-40 deg. C to +85 deg. C

Radio Specification

Equipment Type	Transceiver
Frequency of Operation	76 GHz to 77 GHz
	(FCM 1: 76.3 GHz, 76.7 GHz / FCM 2: 76.5 GHz)
Bandwidth	980 MHz
Type of Modulation	Frequency Modulation (FCM: Fast Chirp Modulation)
Emission Classification	QXN
Antenna Gain	17.0 dBi (typ)
Steerable Antenna	Fixed beam
Usage location	This product is installed behind the vehicle outer body.

Test Report No. 15027824H-A-R2 Page 6 of 41

SECTION 3: Test specification, procedures & results

Test Specification 3.1

Test	FCC Part 95 Subpart M
Specification	The latest version on the first day of the testing period
Title	FCC 47CFR Part95 – PERSONAL RADIO SERVICES
	Subpart M – The 76-81 GHz Band Radar Service

3.2 **Procedures and results**

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted	FCC: N/A	FCC: N/A	N/A	N/A	*1)
emission					
Occupied	FCC: ANSI C63.26-2015	FCC: Section 2.1049	See data.	Complied	Radiated
bandwidth	5.4 Occupied bandwidth				
Radiated Power	FCC: ANSI C63.26-2015	FCC: Section 95.3367		Complied	Radiated
	5.5 Radiated emissions	Section 2.1046			
Modulation	testing	Section 2.1047			
characteristics	ANSI C63.10-2013				
	6. Standard test methods				
	Procedures for testing				
	millimeter-wave systems				
Field strength of	FCC: ANSI C63.26-2015	FCC: Section 95.3379	14.6 dB	Complied	Radiated
spurious radiation	5.5 Radiated emissions	(a)	336.0 MHz, QP,		
	testing	Section 2.1053	Vertical		
		Section 2.1057			
Frequency stability	FCC: ANSI C63.26-2015	FCC: Section 95.3379	See data.	Complied	Radiated
	5.6 Frequency stability	(b)			
	testing	Section 2.1055			

Note: UL Japan, Inc.'s EMI Work Procedures: Work Instructions-ULID-003591 and Work Instructions-ULID-003593. * In case any questions arise about test procedure, ANSI C63.10-2013, ANSI C63.26-2015 and KDB653005 are also referred.

<u>Supplied Voltage Information</u>
This EUT provides stable voltage constantly to RF Module regardless of input voltage.

<u>Antenna Information</u>
The antenna is not removable from the EUT.

3.3 Addition to standard

No addition, exclusion nor deviation has been made from the standard.

^{*1)} The test is not applicable since the EUT is not the device that is designed to be connected to the public utility (AC) power line.

Test Report No. 15027824H-A-R2 Page 7 of 41

3.4 Uncertainty

Measurement uncertainty is not taken into account when stating conformity with a specified requirement. Note: When margins obtained from test results are less than the measurement uncertainty, the test results may exceed the limit.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor k = 2.

Radiated emission

Measurement distance	Frequency range		Uncertainty (+/-)
3 m	9 kHz to 30 MHz		3.3 dB
10 m			3.1 dB
3 m	30 MHz to 200 MHz	Horizontal	4.8 dB
		Vertical	5.0 dB
	200 MHz to 1000 MHz	Horizontal	5.1 dB
		Vertical	6.2 dB
10 m	30 MHz to 200 MHz	Horizontal	4.8 dB
		Vertical	4.8 dB
	200 MHz to 1000 MHz	Horizontal	4.9 dB
		Vertical	5.0 dB
3 m	1 GHz to 6 GHz	Test Receiver	5.1 dB
		Spectrum analyzer	4.9 dB
	6 GHz to 18 GHz	Test Receiver	5.4 dB
		Spectrum analyzer	5.2 dB
1 m	10 GHz to 18 GHz	Spectrum analyzer	5.0 dB
	18 GHz to 26.5 GHz	Spectrum analyzer	5.6 dB
	26.5 GHz to 40 GHz	Spectrum analyzer	4.9 dB
0.5 m	26.5 GHz to 40 GHz	Spectrum analyzer	4.9 dB
10 m	1 GHz to 18 GHz	Test Receiver	5.4 dB
>= 0.5 m	40 GHz to 50 GHz		
	50 GHz to 75 GHz		5.9 dB
	75 GHz to 110 GHz		5.7 dB
>= 3.8 cm	110 GHz to 170 GHz	110 GHz to 170 GHz	
>= 2.5 cm	170 GHz to 260 GHz	170 GHz to 260 GHz	

^{*}under consideration about Uncertainty for testing at 1 cm distance.

Radiated emission (with Block downconverter)

Measurement distance	Frequency range	Uncertainty (+/-)
>= 0.5 m	75 GHz to 83 GHz	3.4 dB*

^{*} This value was used for 75 GHz to 83 GHz in this report.

Test Report No. 15027824H-A-R2 Page 8 of 41

3.5 **Test Location**

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 Japan

Telephone: +81-596-24-8999

A2LA Certificate Number: 5107.02 / FCC Test Firm Registration Number: 884919 ISED Lab Company Number: 2973C / CAB identifier: JP0002

Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance	
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m	
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m	
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m	
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-	
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m	
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-	
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-	
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-	
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-	
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-	
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-	
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-	
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-	
No.10 shielded room	3.8 x 2.8 x 2.8	3.8 x 2.8	-	-	
No.11 measurement room	4.0 x 3.4 x 2.5	N/A	-	-	
No.12 measurement room	2.6 x 3.4 x 2.5	N/A	-	-	
Large Chamber	16.9 x 22.1 x 10.17	16.9 x 22.1	-	10 m	
Small Chamber	5.3 x 6.69 x 3.59	5.3 x 6.69	-	-	

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

Test Report No. 15027824H-A-R2 Page 9 of 41

SECTION 4: Operation of EUT during testing

4.1 Operating Mode(s)

Mode	Test Item			
Transmitting mode (Tx)	- Occupied bandwidth			
- Mode 1	- Radiated Power			
 FCM 1 Low (76.3 GHz) 				
 FCM 1 High (76.7 GHz) 				
• FCM 2				
Transmitting mode (Tx)	- Modulation characteristics			
- Mode 1				
 FCM 1 Low (76.3 GHz) 				
• FCM 2				
Normal operating mode	- Field strength of spurious radiation			
- Mode 1	- Frequency stability			
*Power of the EUT was set by the software as fo	llows;			
Power Setting: 27.98 dBm				

Software: mwr_gen7_0078_t6323_RSR_WINB_withDF

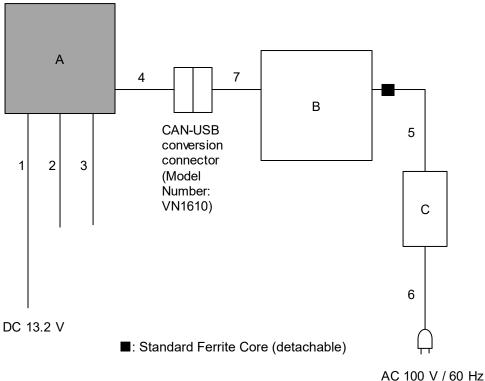
(Date: 2023.11.02, Storage location: EUT memory)

Any conditions under the normal use do not exceed the condition of setting.

In addition, end users cannot change the settings of the output power of the product.

^{*}This setting of software is the worst case.

4.2 Configuration and peripherals



Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
Α	Millimeter Wave	DNMWR017	B1T_2.1W0803	DENSO CORPORATION	EUT
	Radar Sensor		_		
В	Laptop PC	HP ProBook 450 G5	5CD922C9PF	HP	-
С	AC Adapter	HSTNN-CA41	-	HP	-

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Cable	5.0	Unshielded	Unshielded	-
2	Signal Cable	5.0	Unshielded	Unshielded	-
3	USB Cable	0.9	Shielded	Shielded	-
4	CAN Cable	5.5	Unshielded	Unshielded	-
5	DC Cable	1.8	Unshielded	Unshielded	-
6	AC Cable	1.0	Unshielded	Unshielded	-
7	USB Cable	1.0	Shielded	Shielded	-

^{*} Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions. * The test voltage was referred to KDB653005 5.1(e) (FCC), and the test was performed with DC 13.2 V (1.1 times of nominal voltage DC 12 V).

Test Report No. 15027824H-A-R2 Page 11 of 41

SECTION 5: Radiated Spurious Emission

Test Procedure

[For below 30 MHz]

The EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The loop antenna was fixed height at 1.0 m.

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for vertical polarization (antenna angle: 0 deg., 45 deg., 90 deg.,

135 deg., and 180 deg.) and horizontal polarization.

*Refer to Figure 1 about Direction of the Loop Antenna.

[For above 30 MHz, up to 1 GHz]

The EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

[For above 1 GHz, up to 40 GHz]

The EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer.

The test was made with the detector (RBW/VBW) in the following table.

Test Antennas are used as below;

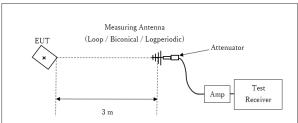
Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

Frequency	9 kHz to 150 kHz	150 kHz to 30 MHz	30 MHz to 1 GHz	1 GHz to 40 GHz
Instrument	Test Receiver			Spectrum Analyzer
used				
Detector	CISPR QP,	CISPR QP, Average	CISPR QP	Average *1)
	Average			
IF Bandwidth	200 Hz	9 kHz	120 kHz	RBW: 1 MHz
				VBW: 3 MHz

^{*1)} A RMS average mode was applied according to KDB653005 4 (b) and 5.4 (f).

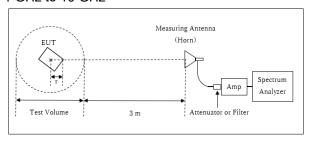
Test Report No. 15027824H-A-R2 Page 12 of 41

[Test setup] Below 1 GHz



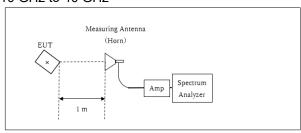
× : Center of turn table

1 GHz to 10 GHz



- r : Radius of an outer periphery of EUT
- ×: Center of turn table

10 GHz to 40 GHz



×: Center of turn table

Test Distance: 3 m

Distance Factor: $20 \times \log (4.0 \text{ m}^*/3.0 \text{ m}) = 2.5 \text{ dB}$ * Test Distance: (3 + Test Volume /2) - r = 4.0 m

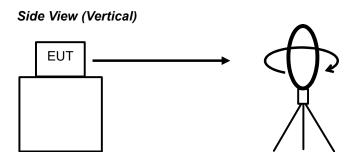
Test Volume: 2 m (Test Volume has been calibrated based on CISPR 16-1-4.) r = 0.0 m

* The test was performed with r = 0.0 m since that yielded the worst emission levels from the EUT.

Distance Factor: $20 \times \log (1.0 \text{ m}^* / 3.0 \text{ m}) = -9.5 \text{ dB}$ *Test Distance: 1 m

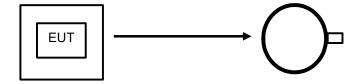
Test Report No. 15027824H-A-R2 Page 13 of 41

Figure 1: Direction of the Loop Antenna



.....

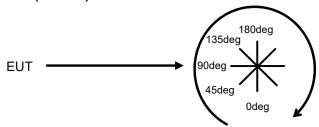
Top View (Horizontal)



Antenna was not rotated.

.....

Top View (Vertical)



Front side: 0 deg.

Forward direction: clockwise

Test Report No. 15027824H-A-R2 Page 14 of 41

[Above 40 GHz (Expext for fundamental measurement)]

The test was performed based on "Procedures for testing millimeter-wave systems" of ANSI C63. 10-2013.

The EUT was placed on a urethane platform, raised 1.5 m above the conducting ground plane. The measurements were performed on handheld method.

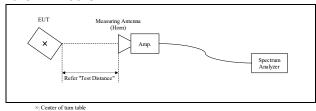
Set spectrum analyzer RBW, VBW, span, etc., to the proper values. Note these values. Enable two traces—one set to "clear write," and the other set to "max hold." Begin hand-held measurements with the test antenna (horn) at a distance of 1 m from the EUT in a horizontally polarized position. Slowly adjust its position, entirely covering the plane 1 m from the EUT. Observation of the two active traces on the spectrum analyzer will allow refined horn positioning at the point(s) of maximum field intensity. Repeat with the horn in a vertically polarized position. If the emission cannot be detected at 1 m, reduce the RBW to increase system sensitivity. Note the value. If the emission still cannot be detected, move the horn closer to the EUT, noting the distance at which a measurement is made.

Note the maximum level indicated on the spectrum analyzer. Adjust this level, if necessary, by the antenna gain, filter loss, conversion loss of the external mixer and gain of LNA used, at the frequency under investigation. Calculate the field strength of the emission at the measurement distance from the Friis' transmission equation.

The final test was performed with a 1 MHz RMS detctor at the following distances;

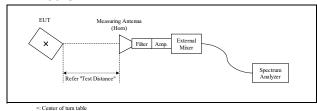
[Test setup]

40 GHz to 50 GHz



*Test Distance: 0.5 m

Above 50 GHz



*Test Distance:

50 GHz to 75 GHz	0.75 m
75 GHz to 110 GHz	0.50 m
110 GHz to 231 GHz	0.01 m

The test results and limit are rounded off to one decimal place, so some differences might be observed.

The noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Test Report No. 15027824H-A-R2 Page 15 of 41

[About fundamental measurement]

The test was performed based on "Procedures for testing millimeter-wave systems" of ANSI C63. 10-2013.

The EUT was placed on a urethane platform, raised 1.5 m above the conducting ground plane. The measurements were performed on handheld method.

The carrier levels were confirmed at maximum direction of transmission. The maximum direction was searched under carefully since beam-widths are extremely narrow.

The carrier levels were measured in the far field. The distance of the far field was calculated from follow equation.

$$r = \frac{2D^2}{\lambda}$$

where

r is the distance from the radiating element of the EUT to the edge of the far field, in m *D* is the largest dimension of both the radiating element and the test antenna (horn), in m (The antenna aperture size of test antenna was used for this caluculation.) *Lambda* is the wavelength of the emission under investigation [300/f (MHz)], in m

Frequency	Wavelength	Ma	aximum Dimensi	Far Field	Tested	
		EUT	Test Antenna	Maximum	Boundary	Distance
	Lambda			D	r	
[GHz]	[mm]	[m]	[m]	[m]	[m]	[m]
77	3.9	0.015460	0.026162	0.026162	0.352	0.5

In order to maximize the carrier level, the EUT, which has a horizontally polarized antenna, and the polarization plane of the measurement antenna were aligned for the test.

The Peak Power results was applied to the desensitization correction factor by KDB653005 4 (c) and 5.4 (d).

The derivation of the FMCW Desensitization Factor is given in Keysight Application Note 5952 1039 Appendix B.

Desensitization factor was calculated from follow equation;

$$\alpha = \frac{1}{\sqrt[4]{1 + \left(\frac{2In(2)}{\pi}\right)^2 \left(\frac{Fs}{Ts B^2}\right)^2}}$$

and

FMCW Desensitization factor = $20 \text{ Log } (\alpha)$

Where

Fs is FMCW Sweep Width or Chirp Width, is used the actual measurement value.

*T*s is FMCW Sweep Time, is referred to the values in the specifications.

B is -3dB Bandwidth of Gaussian RBW Filter, is used the actual measurement value.

Test Report No. 15027824H-A-R2 Page 16 of 41

Tx	Mode	Fs	Ts	В	α	FMCW
						Desensitization
						factor
		[MHz]	[us]	[MHz]		[dB]
	FCM 1 Low	452.0533	54.0	1.0	0.511	-5.83
Mode 1	FCM 1 High	450.6653	54.0	1.0	0.512	-5.82
	FCM 2	895.0769	34.0	1.0	0.293	-10.67

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 9 kHz to 231 GHz

Test data : APPENDIX

Test result : Pass

Test Report No. 15027824H-A-R2 Page 17 of 41

SECTION 6: Frequency Stability

Test Procedure

The block downconverter was placed in side of the temperature chamber's drain hole.

The power supply was set to nominal operating voltage (110 %), and the spectrum mask was measured at 20 deg. C. After that, EUT power supply was varied between 85 % and 115 % of nominal voltage and the frequency excursion of the EUT emission mask was recorded.

The EUT operating temperature was raised to 50 deg. C, and the frequency excursion of the EUT emission mask was recorded. Measurements were repeated at each 10 deg. C decrement down to -20 deg. C.

Both lower and upper frequencies of the -20 dB Bandwidth were recorded.

Test data : APPENDIX

Test result : Pass

Test Report No. 15027824H-A-R2 Page 18 of 41

APPENDIX 1: Test data

Occupied bandwidth

Test place Semi Anechoic Chamber

Temperature / Humidity

Engineer Mode

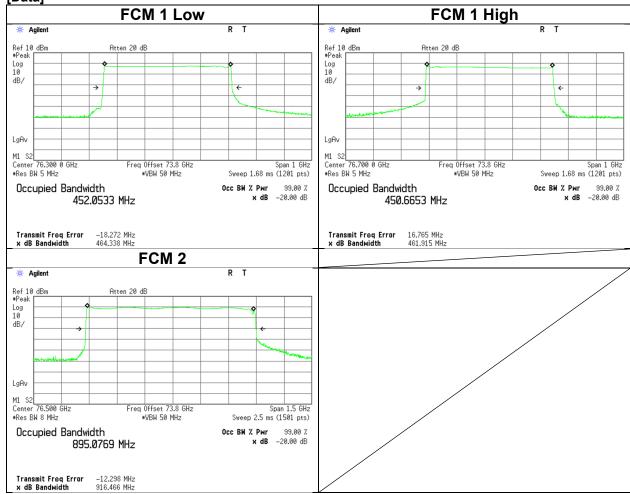
Ise EMC Lab. No. 4

November 2, 2023 22 deg. C / 40 % RH Sayaka Hara

Tx (Mode 1)

Mode	Frequency	99 % Occupied
		bandwidth
	[GHz]	[MHz]
FCM 1 Low	76.3	452.0533
FCM 1 High	76.7	450.6653
FCM 2	76.5	895.0769





The measurement was performed with Peak detector and Max Hold since the duty cycle was not 100 %.

Test Report No. 15027824H-A-R2 Page 19 of 41

Radiated Power

Test place

Semi Anechoic Chamber

Date Temperature / Humidity

Engineer

Mode

Ise EMC Lab.

No. 4

November 5, 2023 23 deg. C / 48 % RH Junki Nagatomi

Tx (Mode 1)

No. 4

November 6, 2023 23 deg. C / 53 % RH

Sayaka Hara

Mode	Power	Freq.	Measured	Rx	Down	IF	Tested	FSL	Duty	FMCW	EI	RP	Lmit	Margin	Remarks
			Power	Ant.	Converter	Cable	Distance		Factor	desensitization					
				Gain	Gain	Loss				Factor					
		[GHz]	[dBm]	[dBi]	[dB]	[dB]	[m]	[dB]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[dB]	
FCM 1	Average	76.300	-11.53	23.05	14.72	1.39	0.5	64.07	4.97	-	21.13	129.72	50	28.87	
Low	Peak	76.249	-2.67	23.05	14.79	1.38	0.5	64.07	-	0.00	24.94	311.89	55	30.06	Marker 1 *1
	Peak	76.460	-3.62	23.05	14.78	1.44	0.5	64.09	-	-5.83	29.91	979.49	55	25.09	Marker 2 *2
FCM 1	Average	76.700	-11.52	23.06	14.69	1.51	0.5	64.12	4.97	-	21.33	135.83	50	28.67	
High	Peak	76.749	-3.05	23.06	14.44	1.53	0.5	64.12	-	0.00	25.10	323.59	55	29.90	Marker 1 *1
	Peak	76.538	-4.00	23.06	15.02	1.46	0.5	64.10	-	-5.82	29.30	851.14	55	25.70	Marker 2 *2
FCM 2	Average	76.500	-18.16	23.06	14.90	1.45	0.5	64.09	12.30	-	21.72	148.59	50	28.28	
	Peak	76.449	-1.89	23.05	14.74	1.44	0.5	64.09	-	0.00	25.85	384.59	55	29.15	Marker 1 *1
	Peak	76.918	-3.86	23.06	14.17	1.57	0.5	64.14	-	-10.67	35.29	3380.65	55	19.71	Marker 2 *2

Calculating formula:

Normala.

FSL (Free Space path Loss) = 10 * log10((4 * Pi * Tested Distance / Lambda) ^2)

Average EIRP = Measured Power - Rx Ant. Gain - Down Converter Gain + IF Cable Loss + FSL + Duty Factor Peak EIRP = Measured Power - Rx Ant. Gain - Down Converter Gain + IF Cable Loss + FSL - FMCW desensitization factor

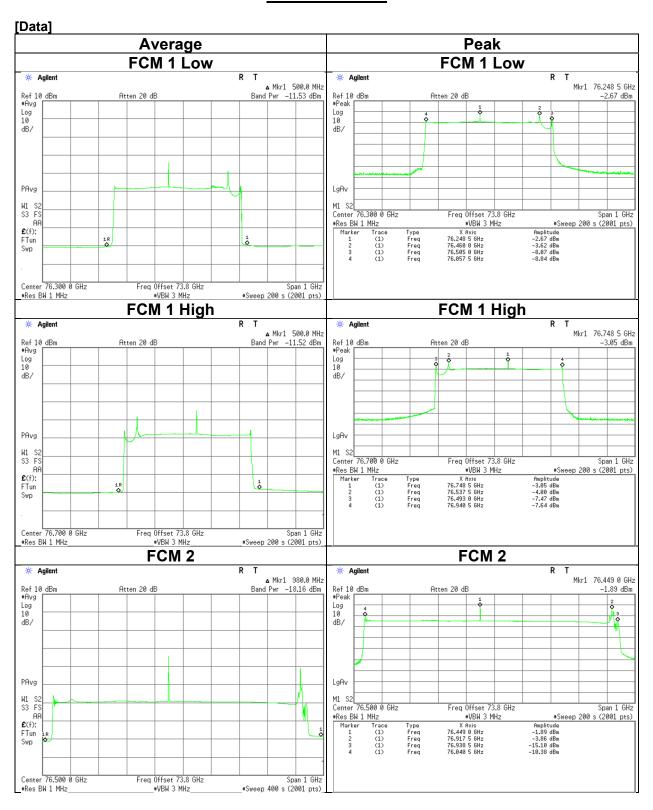
- *1 There was time to stop the FCM frequency sweep, and FMCW desensitization factor was not applied. Refer to Marker1 of Modulation characteristics.
- *2 The desensitization correction coefficient was applied due to the power in FCM operation interval. Refer to FCM1 and FCM2 of Modulation characteristics.

The test method referred to KDB653005 4 and 5.4.

The derivation of the Duty Factor is given in Duty data page.

The derivation of the FMCW Desensitization Factor is given in Keysight Application Note 5952 1039 Appendix B. (Refer Section 5)

Radiated Power



Test Report No. 15027824H-A-R2 Page 21 of 41

Modulation characteristics

Test place Ise EMC Lab.

Semi Anechoic Chamber No. 4

Date November 2, 2023
Temperature / Humidity 22 deg. C / 40 % RH
Engineer Sayaka Hara
Mode Tx (Mode 1) FCM 1

					Tx On time							
		CW section										
	(1 of 8)	(2 of 8)	(3 of 8)	(4 of 8)	(5 of 8)	(6 of 8)	(7 of 8)	(8 of 8)	(Total)			
	[us]	[us]	[us]	[us]	[us]	[us]	[us]	[us]	[us]			
Measured	16.755	28.113	234.900	16.833	28.039	28.078	28.094	320.807	701.620			

	Tx Oı	n time	Tx On	Duty	Duty
	FCM1	Total	+ Tx Off		Factor
	section		time		
	[ms]	[ms]	[ms]	[%]	[dB]
Measured	15.237	15.939	50.002	31.9	4.97

Calculating formula:

Tx On time Maker1 section (Total) = Tx On time CW section (1 of 8) + Tx On time CW section (2 of 8)

+ Tx On time CW section (3 of 8) + Tx On time CW section (4 of 8) + Tx On time CW section (5 of 8)

+ Tx On time CW section (6 of 8) + Tx On time CW section (7 of 8) + Tx On time CW section (8 of 8)

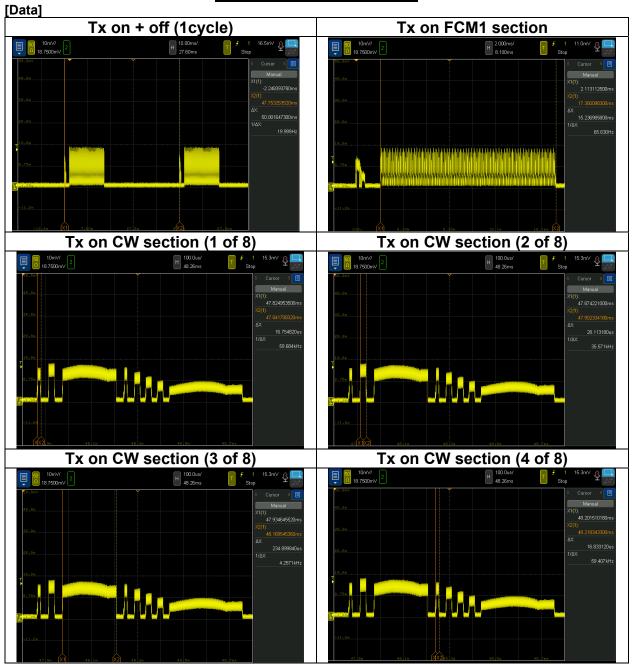
Tx On time (Total) = Tx On time CW section (Total) + Tx On time (FCM1 section)

Duty = (Tx On time (Total) / Tx On + Tx Off time) * 100

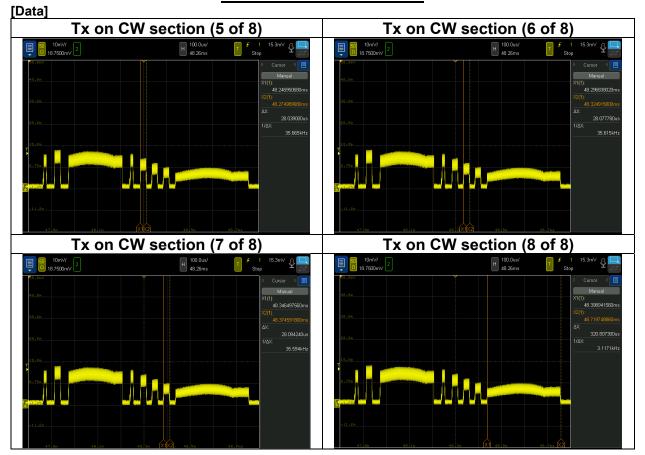
Duty factor = 10 * log (Tx On + Tx Off time / Tx On time (Total))

^{*} See the application document.

Modulation characteristics



Modulation characteristics



Test Report No. 15027824H-A-R2 Page 24 of 41

Modulation characteristics

Test place Ise EMC Lab.

Semi Anechoic Chamber No. 4

Date November 2, 2023
Temperature / Humidity 22 deg. C / 40 % RH
Engineer Sayaka Hara
Mode Tx (Mode 1) FCM 2

ſ						Tx On time							
			CW section										
		(1 of 8)	(2 of 8)	(3 of 8)	(4 of 8)	(5 of 8)	(6 of 8)	(7 of 8)	(8 of 8)	(Total)			
		[us]	[us]	[us]	[us]	[us]	[us]	[us]	[us]	[us]			
Ī	Measured	16.804	28.166	187.145	16.809	28.084	28.159	28.127	320.182	653.476			

	Tx Or	n time	Tx On	Duty	Duty
	FCM 2	Total	+ Tx Off		Factor
	section		time		
	[ms]	[ms]	[ms]	[%]	[dB]
Measured	2.288	2.942	50.000	5.9	12.30

Calculating formula:

Tx On time Maker1 section (Total) = Tx On time CW section (1 of 8) + Tx On time CW section (2 of 8)

+ Tx On time CW section (3 of 8) + Tx On time CW section (4 of 8) + Tx On time CW section (5 of 8)

+ Tx On time CW section (6 of 8) + Tx On time CW section (7 of 8) + Tx On time CW section (8 of 8)

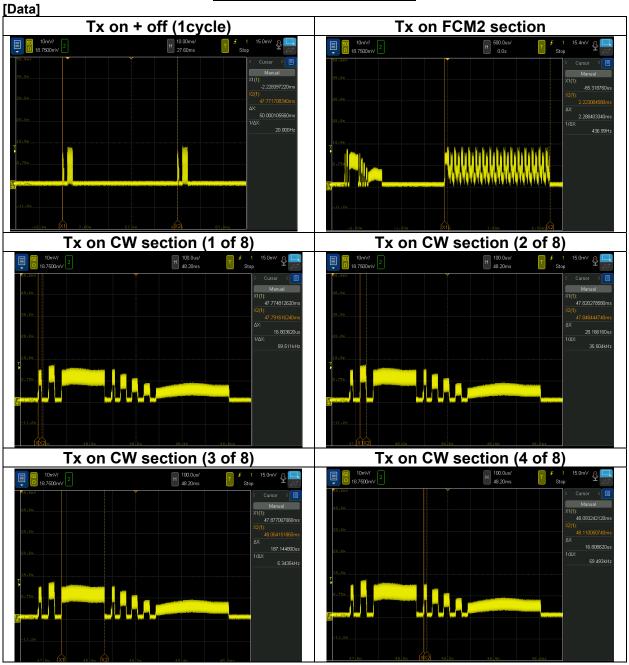
Tx On time (Total) = Tx On time CW section (Total) + Tx On time (FCM2 section)

Duty = (Tx On time (Total) / Tx On + Tx Off time) * 100

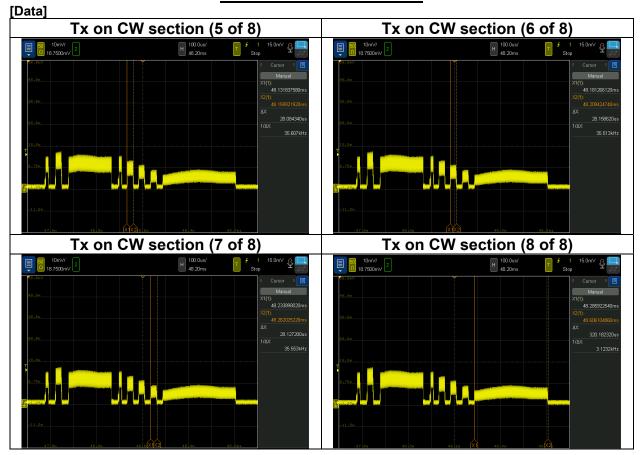
Duty factor = 10 * log (Tx On + Tx Off time / Tx On time (Total))

^{*} See the application document.

Modulation characteristics



Modulation characteristics



Test Report No. 15027824H-A-R2 Page 27 of 41

Field strength of spurious radiation (Below 40 GHz)

Test place Semi Anechoic Chamber Ise EMC Lab.

Date

Temperature / Humidity

Engineer

No. 4 November 6, 2023 22 deg. C / 55 % RH

Junki Nagatomi (10 GHz to 40 GHz) No. 4 November 13, 2023 20 deg. C / 28 % RH

Sayaka Hara (9 kHz to 30 MHz)

No. 4 November 15, 2023 20 deg. C / 38 % RH

Junki Nagatomi (1 GHz to 10 GHz) No. 4 November 14, 2023 22 deg. C / 46 % RH Junki Nagatomi (30 MHz to 1000 MHz)

Mode

Normal operating mode (Mode 1)

Polarity	Frequency	Reading (QP / PK)	Reading (AV)	Ant. Factor	Loss	Gain	Result (QP / PK)	Result (AV)	Limit (QP / PK)	Limit (AV)	Margin (QP / PK)	Margin (AV)	Remark
[Hori/Vert]	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	
Hori.	49.2	26.2	-	11.5	7.3	32.1	12.9	-	40.0	-	27.1	-	
Hori.	320.0	34.4	-	14.2	9.8	32.0	26.3	-	46.0	-	19.7	-	
Hori.	336.0	34.4	-	14.7	9.9	32.0	26.9	-	46.0	-	19.1	-	
Hori.	340.0	33.9	-	14.8	9.9	32.1	26.6	-	46.0	-	19.5	-	
Hori.	400.0	31.7	-	15.7	10.2	32.1	25.5	-	46.0	-	20.5	-	
Hori.	424.0	30.7	-	16.0	10.3	32.1	24.9	-	46.0	-	21.1	-	
Vert.	41.4	27.1	-	14.4	7.2	32.1	16.6	-	40.0	-	23.4	-	
Vert.	320.0	38.6	-	14.2	9.8	32.0	30.5	-	46.0	-	15.5	-	
Vert.	336.0	38.9	-	14.7	9.9	32.0	31.4	-	46.0	-	14.6	-	
Vert.	340.0	38.0	-	14.8	9.9	32.1	30.7	-	46.0	-	15.4	-	
Vert.	400.0	30.5	-	15.7	10.2	32.1	24.3	-	46.0	-	21.7	-	
Vert.	424.0	29.5	-	16.0	10.3	32.1	23.7	-	46.0	-	22.3	-	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Distance factor:

1 GHz - 10 GHz

10 GHz - 40 GHz

20log (4.0 m / 3.0 m) = 2.5 dB $20\log (1.0 \text{ m} / 3.0 \text{ m}) = -9.5 \text{ dB}$

^{*}Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

^{*}QP detector was used up to 1GHz.

Test Report No. 15027824H-A-R2 Page 28 of 41

Field strength of spurious radiation (Below 40 GHz) (Plot data, Worst case)

Test place Semi Anechoic Chamber

Temperature / Humidity Engineer

Mode

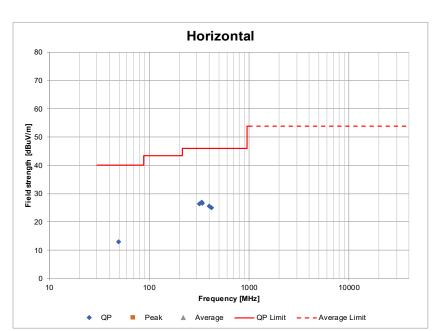
Ise EMC Lab.

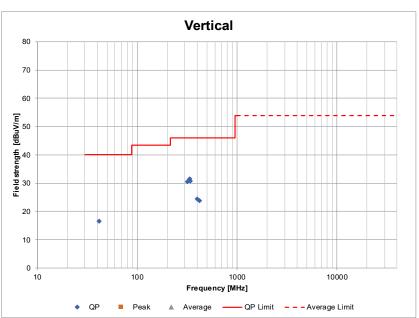
No. 4 November 6, 2023 22 deg. C / 55 % RH Junki Nagatomi (10 GHz to 40 GHz)

No. 4 November 13, 2023 20 deg. C / 28 % RH Sayaka Hara (9 kHz to 30 MHz) Normal operating mode (Mode 1)

November 15, 2023 20 deg. C / 38 % RH Junki Nagatomi (1 GHz to 10 GHz)

No. 4 November 14, 2023 22 deg. C / 46 % RH Junki Nagatomi (30 MHz to 1000 MHz)





^{*}These plots data contains sufficient number to show the trend of characteristic features for EUT.

Test Report No. 15027824H-A-R2 Page 29 of 41

170 GHz)

Field strength of spurious radiation (Above 40 GHz)

Test place Ise EMC Lab.

Semi Anechoic No.4 No.4 No.4 No.4 No.4

Chamber

Date November 7, 2023 November 8, 2023 November 8, 2023 November 13,

2023

231 GHz)

 Temperature /
 24 deg. C /
 22 deg. C /
 23 deg. C /
 23 deg. C /
 20 deg. C /

 Humidity
 32 % RH
 41 % RH
 40 % RH
 42 % RH
 40 % RH

Engineer Sayaka Hara Junki Nagatomi Sayaka Hara Junki Nagatomi Junki Nagatomi Junki Nagatomi (75 GHz to (40 GHz to (81 GHz to (110 GHz to (170 GHz to

110 GHz)

76 GHz) 75 GHz)
Mode Normal operating mode (Mode 1)

Frequency	Reading	Rx	Filter	LNA	Mixer	IF	IF	Meas.	FSL	EI	RP	Pow	er density a	t 3 m	Remarks
		Ant.	loss	gain	conversion	Amp.	Cable	range		Re	sult	Result	Limit	Margin	
		gain			loss	gain	loss	D							
[GHz]	[dBm]	[dBi]	[dB]	[dB]	[dB]	[dB]	[dB]	[m]	[dB]	[dBm]	[mW]	[pW/cm2]	[pW/cm2]	[dB]	
47.917	-60.97	22.21	0.00	32.81	0.00	0.00	8.17	0.5	60.03	-47.79	0.00002	0.01	600	46.10	NS
50.614	-75.13	22.84	0.31	26.36	47.17	32.03	0.10	0.75	64.03	-44.76	0.00003	0.03	600	43.07	NS
58.617	-75.52	23.67	0.31	25.71	46.82	32.03	0.10	0.75	65.30	-44.40	0.00004	0.03	600	42.71	NS
67.395	-75.50	24.20	0.44	23.19	48.52	32.03	0.10	0.75	66.52	-39.34	0.00012	0.10	600	37.66	NS
69.634	-75.84	24.30	0.52	21.35	48.96	32.03	0.10	0.75	66.80	-37.14	0.00019	0.17	600	35.46	NS
73.625	-76.05	24.46	0.92	21.24	51.29	32.03	0.10	0.75	67.28	-34.19	0.00038	0.34	600	32.50	NS
75.744	-75.26	23.02	0.00	0.00	-14.88	0.00	1.22	0.5	64.01	-47.93	0.00002	0.01	600	46.25	Average detected
81.501	-70.47	23.44	2.30	0.00	-12.48	0.00	2.48	0.5	64.64	-36.97	0.00020	0.18	600	35.28	NS
84.845	-57.31	23.68	2.40	31.64	0.00	0.00	0.00	0.5	64.99	-45.24	0.00003	0.03	600	43.56	NS
99.528	-47.75	24.45	0.46	33.71	0.00	0.00	0.00	0.5	66.38	-39.07	0.00012	0.11	600	37.38	NS
102.444	-49.34	24.56	0.41	32.25	0.00	0.00	0.00	0.5	66.63	-39.11	0.00012	0.11	600	37.43	NS
117.666	-91.73	22.56	0.00	18.36	55.94	0.00	0.00	0.01	33.85	-42.86	0.00005	0.05	600	41.18	NS
119.066	-91.17	22.61	0.00	18.70	52.73	0.00	0.00	0.01	33.96	-45.79	0.00003	0.02	600	44.11	NS
127.356	-92.77	22.87	0.00	20.84	54.27	0.00	0.00	0.01	34.54	-47.67	0.00002	0.02	600	45.98	NS
138.998	-93.28	23.17	0.00	19.23	52.39	0.00	0.00	0.01	35.30	-47.98	0.00002	0.01	600	46.30	NS
147.574	-93.43	23.30	0.00	18.41	56.44	0.00	0.00	0.01	35.82	-42.88	0.00005	0.05	600	41.20	NS
150.470	-93.94	23.33	0.00	17.93	57.89	0.00	0.00	0.01	35.99	-41.32	0.00007	0.07	600	39.63	NS
161.822	-94.00	23.40	0.00	15.56	58.12	0.00	0.00	0.01	36.62	-38.22	0.00015	0.13	600	36.54	NS
163.290	-94.77	23.40	0.00	15.28	60.88	0.00	0.00	0.01	36.70	-35.87	0.00026	0.23	600	34.18	NS
176.757	-88.49	22.56	0.00	0.00	57.62	0.00	0.00	0.01	37.39	-16.04	0.02490	22.01	600	14.35	NS
181.695	-89.48	22.67	0.00	0.00	56.90	0.00	0.00	0.01	37.63	-17.63	0.01728	15.28	600	15.94	NS
187.497	-90.00	22.79	0.00	0.00	56.65	0.00	0.00	0.01	37.90	-18.24	0.01499	13.26	600	16.56	NS
199.002	-90.77	23.00	0.00	0.00	55.54	0.00	0.00	0.01	38.42	-19.81	0.01044	9.23	600	18.13	NS
203.549	-90.47	23.07	0.00	0.00	57.84	0.00	0.00	0.01	38.62	-17.08	0.01958	17.31	1000	17.62	NS
210.164	-90.91	23.17	0.00	0.00	56.78	0.00	0.00	0.01	38.89	-18.40	0.01444	12.77	1000	18.94	NS
220.960	-91.28	23.28	0.00	0.00	62.26	0.00	0.00	0.01	39.33	-12.97	0.05043	44.59	1000	13.51	NS
226.813	-91.09	23.32	0.00	0.00	63.20	0.00	0.00	0.01	39.56	-11.66	0.06825	60.35	1000	12.19	NS

Calculation:

FSL (Free Space path Loss) = 10 * log ($(4 * Pi * D / \lambda)^2$)

EIRP = Reading - Rx Ant. gain + Filter loss - LNA gain + Mixer conversion loss - IF Amp. gain + IF Cable loss + FSL Power density Result at 3 m = EIRP / (4 * Pi * 300²)

These calculation results are same as results which were calculated with formulas described in the Section 9 of ANSI C63.10-2013.

The equipment were not used for factor 0 dB of the data sheets.

The Mixer conversion loss and IF Cable Loss are automatically corrected in the mixer, so the factor of data sheet were 0 dB.

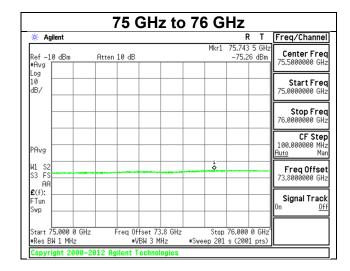
The IF Cable loss is included in Mixer loss, so the factor of data sheet were 0 dB.

NS: No signal detected.

Test Report No. 15027824H-A-R2 Page 30 of 41

Field strength of spurious radiation (Above 40 GHz)

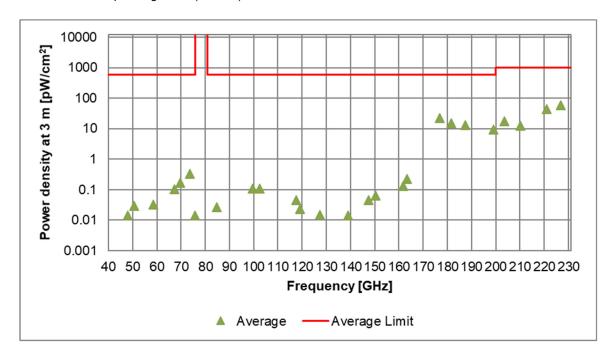
(Data only for detected frequencies)



Test Report No. 15027824H-A-R2 Page 31 of 41

Field strength of spurious radiation (Above 40 GHz) (Plot data, Worst case)

Test place Semi Anechoic Chamber	Ise EMC Lab. No.4	No.4	No. 4	No. 4	No. 4
Date	November 7, 2023	November 7, 2023	November 8, 2023	November 8, 2023	November 13, 2023
Temperature /	24 deg. C /	22 deg. C /	23 deg. C /	23 deg. C /	20 deg. C /
Humidity	32 % RH	41 % RH	40 % RH	42 % RH	40 % RH
Engineer	Sayaka Hara	Junki Nagatomi	Sayaka Hara	Junki Nagatomi	Junki Nagatomi
-	(75 GHz to	(40 GHz to	(81 GHz to	(110 GHz to	(170 GHz to
	`76 GHz)	`75 GHz)	110 GHz)	`170 GHz)	231 GHz)
Mode	Normal operating mo	ode (Mode 1)	,	,	,



^{*}These plots data contains sufficient number to show the trend of characteristic features for EUT.

Test Report No. 15027824H-A-R2 Page 32 of 41

Frequency Stability

Test place Ise EMC Lab.

Measurement Room No. 6

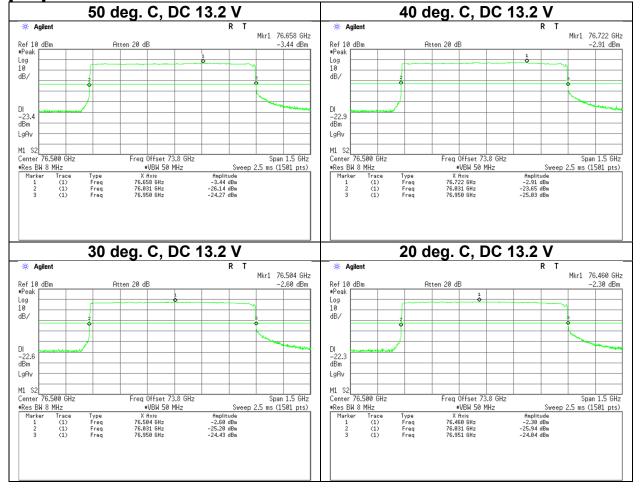
Date November 20, 2023
Temperature / Humidity 24 deg. C / 32 % RH
Engineer Yuichiro Yamazaki

Mode Normal operating mode (Mode 1)

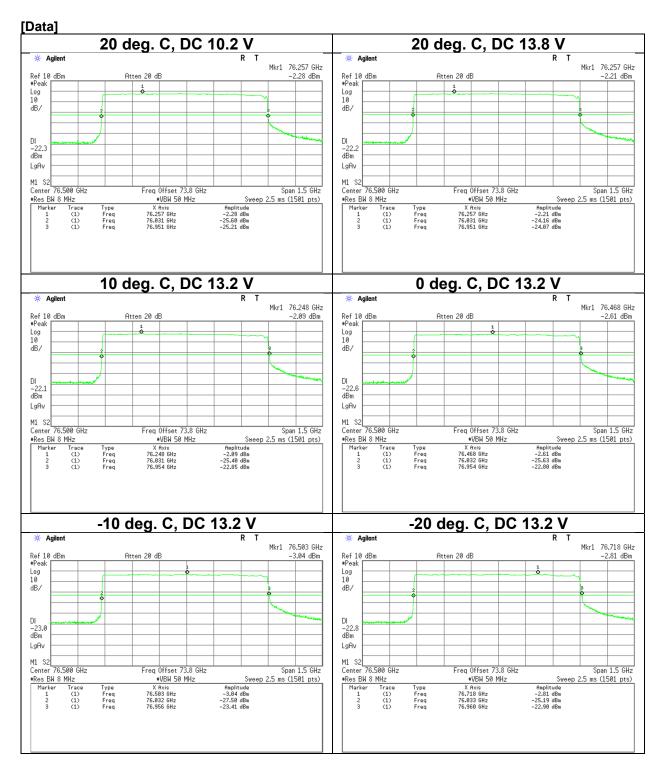
Test Co	ondition	20 dB Ba	andwidth	Remarks
Temperature	Power	The lower	The Upper	
	Supply	frequency	frequency	
[deg. C]	[V]	[GHz]	[GHz]	
50	13.2	76.031	76.950	
40	13.2	76.031	76.950	
30	13.2	76.031	76.950	
20	13.2	76.031	76.051	
20	10.2	76.031	76.951	85 % of the minimum operating voltage, DC 12 V * 0.85
20	13.8	76.031	76.951	115 % of the maximum operating voltage, DC 12 V * 1.15
10	13.2	76.031	76.054	
0	13.2	76.032	76.954	
-10	13.2	76.032	76.956	
-20	13.2	76.033	76.960	

Fundamental emissions were contained within the frequency band 76 GHz to 81 GHz during all conditions of operation.





Frequency Stability



Test Report No. 15027824H-A-R2 Page 34 of 41

APPENDIX 2: Test instruments

Test equipment (1/2)

Test e	quipme	nt (1/2)					
Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
RE	141217	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W/SFM141/ 421-010/ sucoform141-PE/ RFM-E121(SW)	-/04178	06/27/2023	12
RE	141227	Microwave Cable	Junkosha	MMX221- 00500DMSDMS	1502S305	03/03/2023	12
RE	141267	Logperiodic Antenna (200-1000MHz)	Schwarzbeck Mess-Elektronik OHG	VUSLP9111B	9111B-192	09/21/2023	12
RE	141328	Microwave Cable 1G-40GHz	Suhner	SUCOFLEX102	28636/2	04/10/2023	12
RE	141331	Attenuator(6dB)	TME	UFA-01	-	02/01/2023	12
RE	141397	Coaxial Cable	UL Japan	-	-	11/18/2022	12
RE	141425	Biconical Antenna	Schwarzbeck Mess-Elektronik OHG	VHA9103+BBA9106	VHA 91031302	08/10/2023	12
RE	141429	Temperature and Humidity Chamber	Espec	PL-2KP	14015723	08/09/2023	12
RE	141506	Horn Antenna 15-40GHz	Schwarzbeck Mess-Elektronik OHG	BBHA9170	BBHA9170307	08/09/2023	12
RE	141508	Horn Antenna 1-18GHz	Schwarzbeck Mess-Elektronik OHG	BBHA9120D	557	05/17/2023	12
RE	141545	DIGITAL HITESTER	HIOKI E.E. CORPORATION	3805	51201148	01/18/2023	12
RE	141558	Digital Tester(TRUE RMS MULTIMETER)	Fluke Corporation	115	17930030	05/29/2023	12
RE	141561	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	1401	01/13/2023	12
RE	141562	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	0010	01/13/2023	12
RE	141581	MicroWave System Amplifier	Keysight Technologies Inc	83017A	00650	10/05/2023	12
RE	141583	Pre Amplifier	SONOMA INSTRUMENT	310	260833	04/05/2023	12
RE	141899	Spectrum Analyzer	Keysight Technologies Inc	E4448A	MY46180655	02/20/2023	12
RE	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	05/17/2023	12
RE	142011	AC4_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	05/22/2022	24
RE	142017	AC4_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	10/11/2023	12
RE	142026	Diplexer	OML INC.	DPL26	-	11/25/2022	12
RE	142032	Microwave Cable	Huber+Suhner	SUCOFLEX102	37511/2	-	-
RE	142033	Microwave Cable	Huber+Suhner	SUCOFLEX102	37512/2	-	-
RE	142036	Horn Antenna	Custom Microwave Inc.	HO6R	-	09/05/2023	12
RE	142039	Horn Antenna	Custom Microwave Inc.	HO4R	-	09/05/2023	12
RE	142047	Mixer	Keysight Technologies Inc	11974V-E01	3001A00412	11/25/2022	12
RE	142049	Harmonic Mixer	OML INC.	M06HWD	D100709-1	11/25/2022	12
RE	142050		Keysight Technologies Inc	PS-X30-W10117A	13715	03/16/2023	12
RE	142055	Power Amplifier	SAGE Millimeter, Inc.	SBP-5037532015- 1515-N1	11599-01	03/22/2023	12
RE	142152	Loop Antenna	Rohde & Schwarz	HFH2-Z2	836553/009	10/17/2023	12
RE	142225	Tape Measure	ASKUL	- KMC 20	-	-	-
RE RE	142230 142529	Measure, Tape, Steel Detector	KOMELON HEROTEK, INC.	KMC-36 DT1840P	484823	-	+
RE	142529	Horn Antenna	Schwarzbeck Mess-Elektronik	BBHA9120LF	224	-	-
RE	154635	High Pass Filter 83 GHz - 110 GHz	Oshima Prototype Engineering Co.	A17-016	1	05/17/2023	12
RE	159670	Coaxial Cable	UL Japan	-	-	11/18/2022	12
RE	160324	Coaxial Cable	Huber+Suhner	SUCOFLEX 102A	MY009/2A	10/05/2023	12
RE	176027	D-Band Low Noise Amplifier	SAGE Millimeter, Inc.	SBL-1141741860- 0606-EI	15235-01	07/11/2023	12
RE	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
RE	180544	Horn Antenna	SAGE Millimeter, Inc.	SAZ-2410-10-S1	17343-01	06/21/2023	12
RE	180607	Power Amplifier	SAGE Millimeter, Inc.	SBP-7531142515- 1010-E1	17343-01	09/22/2023	12
				SAZ-2410-15-S1	•	I .	12

Test Report No. 15027824H-A-R2 Page 35 of 41

Test equipment (2/2)

Test Item	LIMS ID	Description	Manufacturer	Model		Last Calibration Date	Cal Int
RE	182484	Signal Analyzer	Keysight Technologies Inc	N9030B	MY57143159	04/14/2023	12
RE	183867	WR-10 HighPass Filter	Oshima Prototype Engineering Co.	A19-206	001	03/23/2023	12
RE	186077	Wave guide Harmonic Mixer	Keysight Technologies Inc	M1971W	MY56390146	05/26/2023	12
RE	201432	WR-15 Low Pass Filter	Oshima Prototype Engineering Co.	2020-0142-02	001	09/13/2023	12
RE	211944	Digital Storage Oscilloscope	Keysight Technologies Inc	DSOX6002A	MY59380318	11/07/2022	12
RE	234602	Microwave Cable	Huber+Suhner	SF126E/11PC35/ 11PC35/1000M,5000M	537063/126E / 537074/126E	03/16/2023	12
RE	142053	Harmonic Mixer	OML INC.	M04HWD	Y100709-1	05/16/2023	12

^{*}Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month. As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

Test Item: RE: Radiated Emission